

FDZ2554PZ

Monolithic Common Drain P-Channel 2.5V Specified PowerTrench® BGA MOSFET

General Description

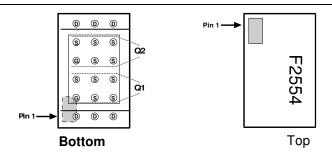
Combining Fairchild's advanced 2.5V specified PowerTrench process with state-of-the-art BGA packaging, the FDZ2554PZ minimizes both PCB space and $R_{\rm DS(ON)}.$ This monolithic common drain BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $R_{\rm DS(ON)}.$

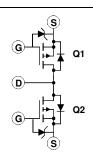
Applications

- · Battery management
- Load switch
- · Battery protection

Features

- -6.5 A, -20 V. $R_{DS(ON)} = 28 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 45 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
- >4800V ESD Protection
- Occupies only 0.10 cm² of PCB area: 1/3 the area of SO-8
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Outstanding thermal transfer characteristics: significantly better than SO-8
- Ultra-low Q_a x R_{DS(ON)} figure-of-merit
- High power and current handling capability





Absolute Maximum Ratings T_{A=25°C} unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		-20	V
V_{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	-6.5	Α
	Pulsed		-20	
P _D	Power Dissipation (Steady State)	(Note 1a)	2.1	W
T_J , T_{STG}	Operating and Storage Junction Temperature Range		−55 to +150	°C

Thermal Characteristics

R _{eJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	60	°C/W
R _{eJB}	Thermal Resistance, Junction-to-Ball	(Note 1b)	6.3	
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	0.6	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
2554Z	FDZ2554PZ	7"	12mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		ı			I
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		-13		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-0.6	-0.8	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -6.5 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -5 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -6.5 \text{ A}, T_J=125^{\circ}\text{C}$		21 36 30	28 45 43	mΩ
g FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -6.5 \text{ A}$		24		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		1430		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		320		pF
C _{rss}	Reverse Transfer Capacitance	1		170		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		9.2		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A},$		15	26	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		9	18	ns
t _{d(off)}	Turn-Off Delay Time	1		60	100	ns
t _f	Turn-Off Fall Time	1		37	60	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V}, \qquad I_{D} = -6.5 \text{ A},$		15	21	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		3		nC
Q_{gd}	Gate-Drain Charge	1		4		nC
Drain_Sc	ource Diode Characteristics	and Maximum Ratings		•		•
Is	Maximum Continuous Drain-Source				-1.75	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.75 \text{ A}$ (Note 2)		-0.7	-1.2	V
t _{rr}	Reverse Recovery Time	$I_F = -6.5 \text{ A},$		25	_	ns
Q _{rr}	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$		10		nC

Notes: 1. $R_{\text{e,JA}}$ is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, $R_{\text{e,JB}}$, is defined for reference. For $R_{\text{e,JC}}$, the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{\text{e,JC}}$ and $R_{\text{e,JB}}$ are guaranteed by design while $R_{\text{e,JA}}$ is determined by the user's board design.

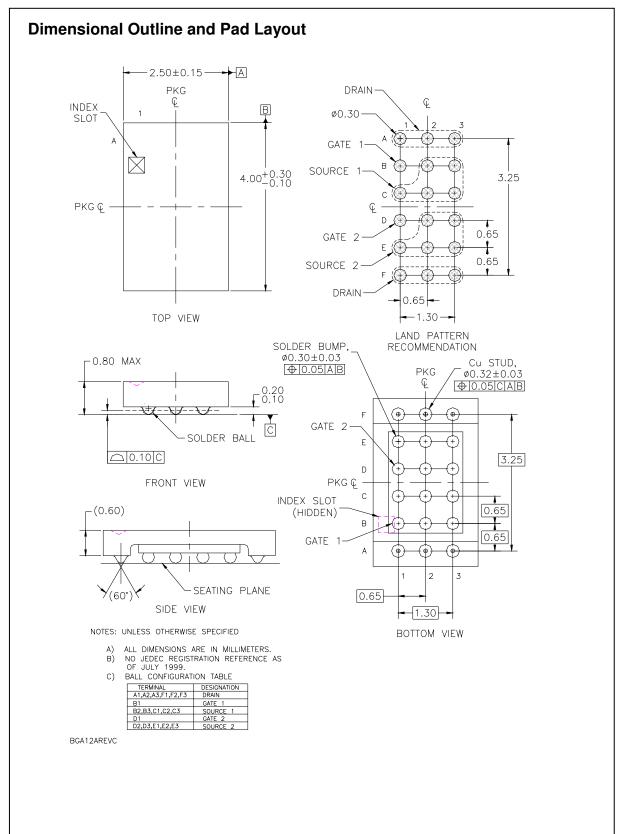


a) 60 °C/W when mounted on a 1in² pad of 2 oz copper

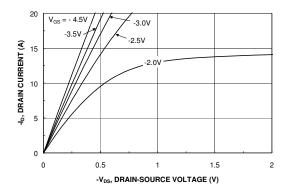


b) 108 °C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper 2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%



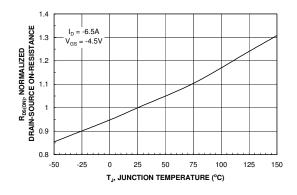
Typical Characteristics



1.8

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



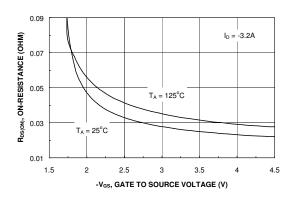
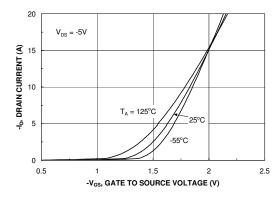


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



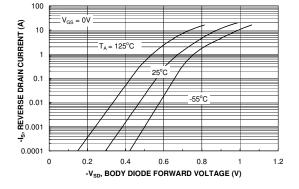
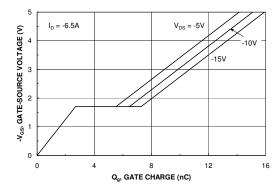


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



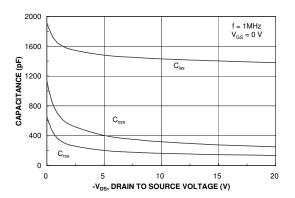


Figure 7. Gate Charge Characteristics.

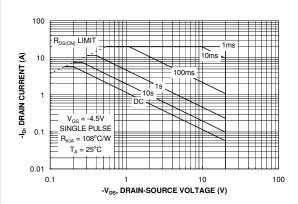


Figure 8. Capacitance Characteristics.

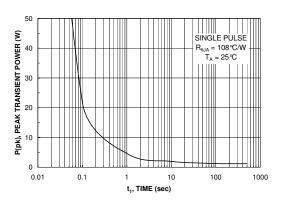


Figure 9. Maximum Safe Operating Area.



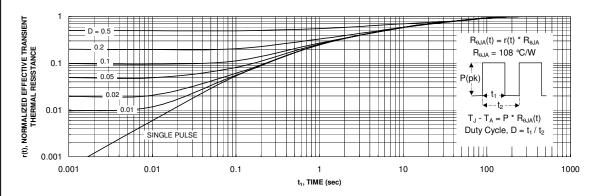


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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